

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
-18V	5.6mΩ@-4.5V	-45A
	6.0mΩ@-3.7V	
	7.0mΩ@-2.5V	
	10.0mΩ@-1.8V	

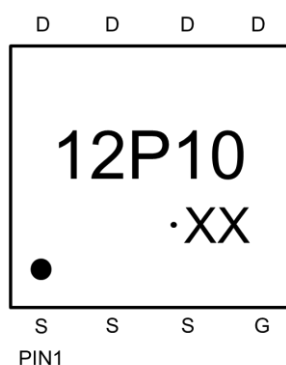
Feature

- High cell density trench P-ch MOSFETs
- Super low gate charge
- Advanced high cell density Trench technology

Application

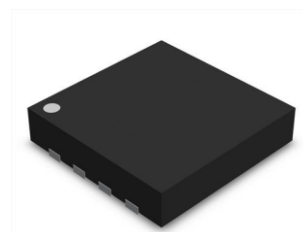
- Battery protection applications
- Load switch

MARKING:

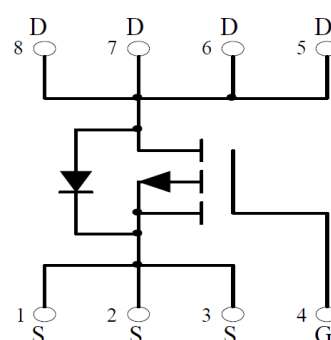


12P10 = Device code
Solid dot1 = Pin1 indicator
Solid dot2 = Green device, if none, normal device
XX = Date Code

DFNWB3×3-08L-C



Schematic diagram



ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-18	V
Gate-Source Voltage	V_{GS}	±8	V
Continuous Drain Current ¹	I_D	-45	A
Pulsed Drain Current ¹	I_{DM}	-135	A
Power Dissipation ²	P_D	3	W
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	42	$^{\circ}\text{C/W}$
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^{\circ}\text{C}$

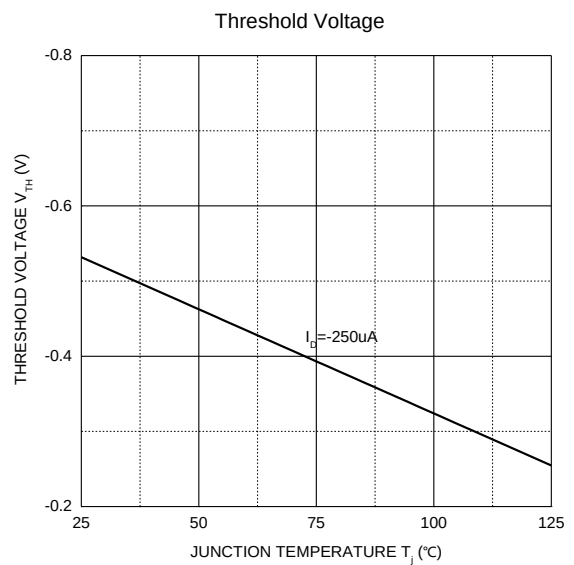
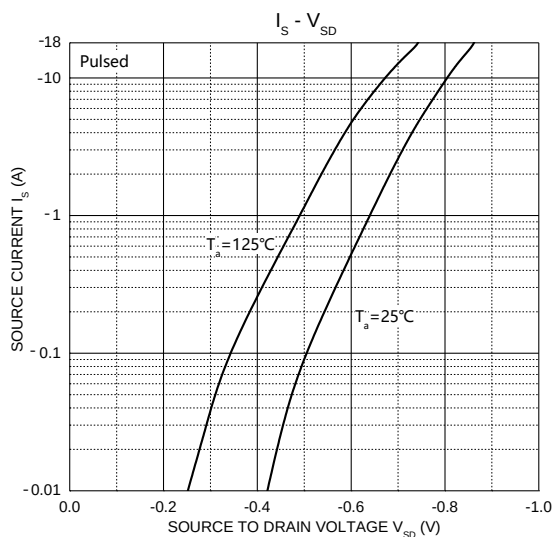
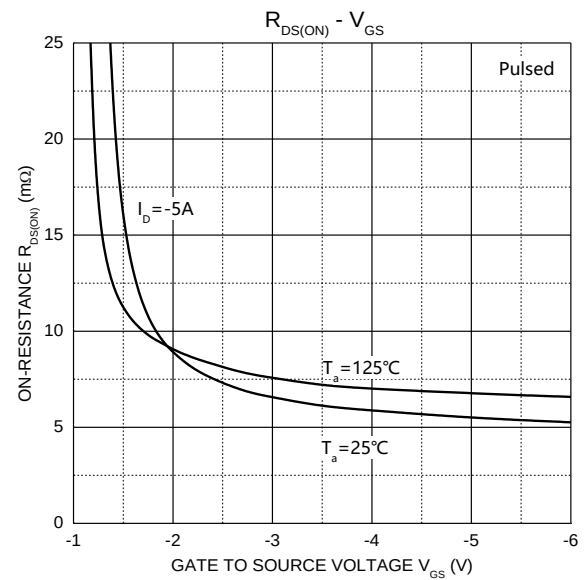
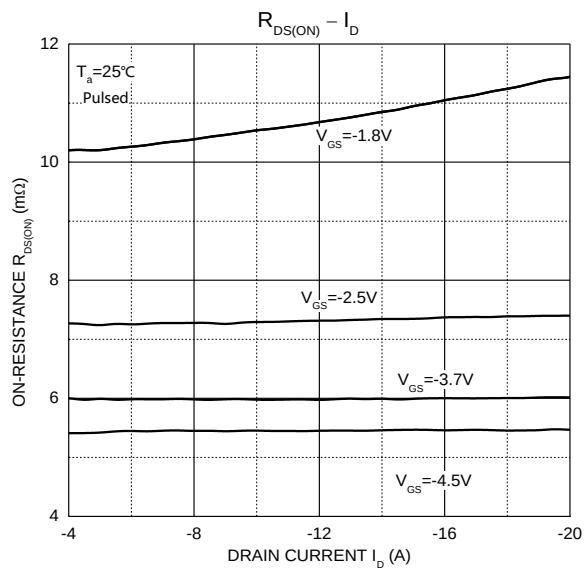
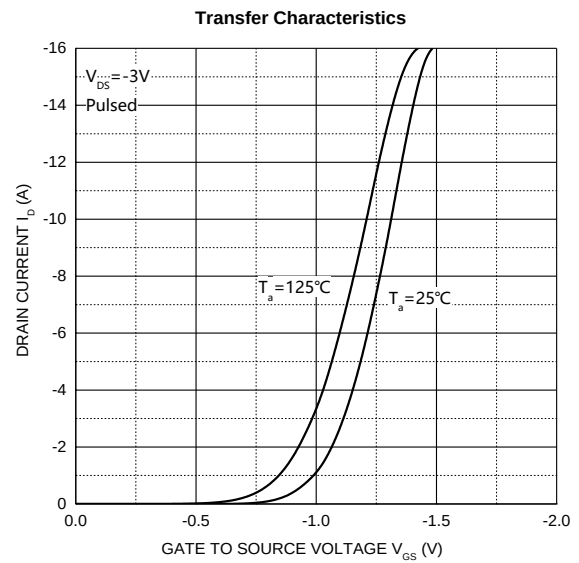
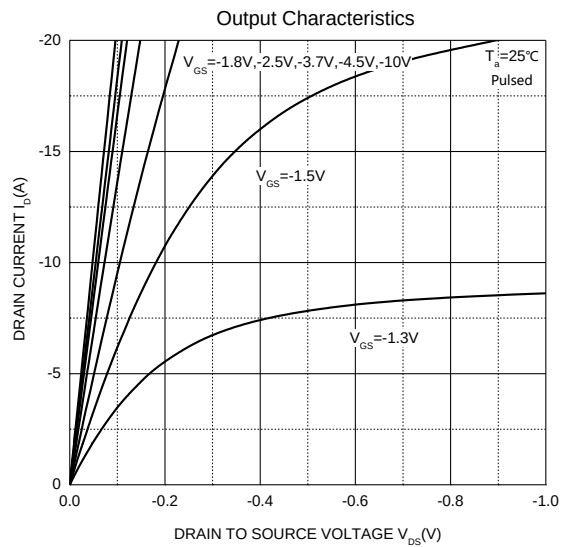
MOSFET ELECTRICAL CHARACTERISTICS($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =-250μA	-18			V
Zero gate voltage drain current	I _{DSS}	V _{DS} =-16V,V _{GS} = 0V			-1	μA
Gate-body leakage current	I _{GSS}	V _{GS} =±8V, V _{DS} = 0V			±100	nA
Gate threshold voltage ³	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-0.35	-0.5	-1	V
Drain-source on-resistance ³	R _{DS(on)}	V _{GS} =-4.5V, I _D =-10A		5.6	7.3	mΩ
		V _{GS} =-3.7V, I _D =-10A		6.0	7.8	
		V _{GS} =-2.5V, I _D =-8A		7.0	9.4	
		V _{GS} =-1.8V, I _D =-6A		10	15	
Forward tranconductance ³	g _{FS}	V _{DS} =-6V, I _D =-10A	5			S
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} =-6V,V _{GS} =0V,f =1MHz		4850		pF
Output Capacitance	C _{oss}			1520		
Reverse Transfer Capacitance	C _{rss}			1610		
Gate resistance	R _g	f =1MHz			30	Ω
Total Gate Charge	Q _g	V _{DS} =-6V,V _{GS} =-4.5V,I _D =-5A		65		nC
Gate-Source Charge	Q _{gs}			20		
Gate-Drain Charge	Q _{gd}			325		
Turn-on delay time	t _{d(on)}	V _{DD} =-6V,V _{GEN} =-4.5V,I _D =-4A R _L =6Ω,R _{GEN} =1Ω		22		ns
Turn-on rise time	t _r			50		
Turn-off delay time	t _{d(off)}			100		
Turn-off fall time	t _f			30		
Source-Drain Diode characteristics						
Diode forward current ⁴	I _S	T _C =25°C			-45	A
Diode pulsed forward curren ⁴	I _{SM}				-135	A
Diode Forward voltage ³	V _{DS}	V _{GS} =0V, I _S =-10A			-1.2	V

Notes:

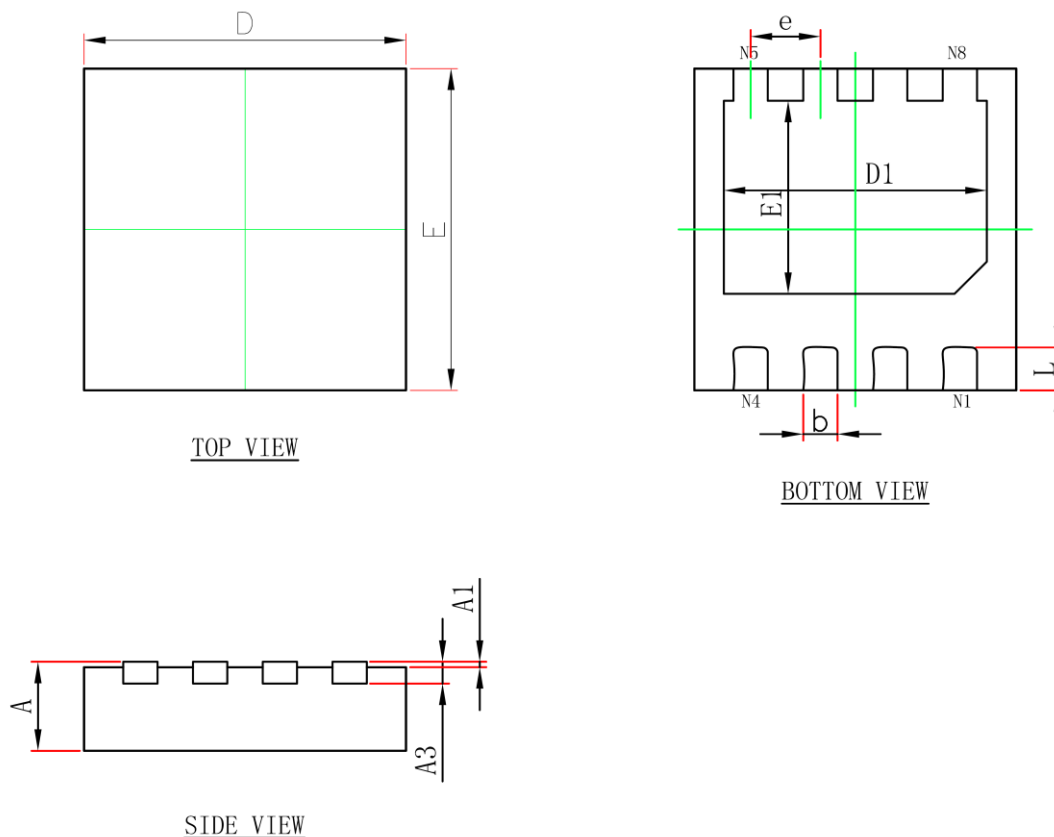
1. Device mounted on FR-4 substrate board, with minimum recommended pad layout, single side.
2. The power dissipation is limited by 150°C junction temperature
3. Pulse Test : Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. The data is theoretically the same as I_D , in real applications , should be limited by total power dissipation.

Typical Electrical and Thermal Characteristics



DFNWB3×3-08L-C Package Information

DFNWB3×3-08L-C (P0.65T0.75) PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031
A1	0.000	0.050	0.000	0.002
A3	0.203REF		0.008REF	
D	2.924	3.076	0.115	0.121
E	2.924	3.076	0.115	0.121
D1	2.350	2.550	0.093	0.100
E1	1.700	1.900	0.067	0.075
k	0.200MIN.		0.008MIN.	
b	0.270	0.370	0.011	0.015
e	0.650TYP.		0.026TYP.	
L	0.324	0.476	0.013	0.019